## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Patent Application of:

Tomiji Tanaka, et al

Application No.: Not Yet Assigned

Confirmation No.: N/A

Filed: May 19, 2006

Art Unit: N/A

For:

**EXTERNAL CAVITY TYPE** 

SEMICONDUCTOR LASER

Examiner: Not Yet Assigned

## **INFORMATION DISCLOSURE STATEMENT (IDS)**

MS PCT Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

In accordance with the requirements of 37 CFR §§ 1.56 and MPEP 609, applicant through his attorneys and representatives, hereby brings to the attention of the Examiner the references noted on the attached Form PTO-1449, copies of which are enclosed.

The references are cited in the International Search Report of applicant's corresponding PCT Application No. PCT/JP2004/018101, a copy of which is enclosed.

It is requested that the Examiner review the reference noted and make such consideration of record.

By

Dated: May 19, 2006

Respectfully submitted,

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## IAP20 Rec'd PCT/PTO 19 MAY 2006

PTO/SB/08a/b (07-05)

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Substitute for form 1449A/B/PTO				Complete if Known		
		•		Application Number	Not Yet Assigned 15	
INFORMATION DISCLOSURE				Filing Date	Concurrently Herewith	
S	TATEMENT	3Y /	APPLICANT	First Named Inventor	Tomiji Tanaka	
				Art Unit	N/A	
	(Use as many sho	eets as	necessary)	Examiner Name	Not Yet Assigned	
Sheet	1	of	1	Attorney Docket Number	SON-3163	

U.S. PATENT DOCUMENTS						
Examiner Initials*	Cite No.1	Document Number  Number-Kind Code <sup>2</sup> ( if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	
	AA*					
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	FOREIGN PATENT DOCUMENTS							
Examiner Initials*	Cite No.1	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear			
		Country Code <sup>3</sup> -Number <sup>4</sup> -Kind Code <sup>5</sup> (if known)				۳°		
	ВА	JP 2002-131583	05-09-02	Furukawa Electric Co., Ltd.		1		
	ВВ	JP 2003-283036	10-03-2003	Furukawa Electric Co., Ltd.		1		
	BC					1		
	BD							
	BE							
	BF							
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NON PATENT LITERATURE DOCUMENTS						
Examiner Initials Cite No.1 Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (boo magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.						
_	CA	International Search Report mailed March 1, 2005				
	СВ	Takashi Mizuno, et al., "100mW Kink Free, Tei-Aspect-hi Aomurasakiiro Handotai Laser," Proceeding of the 11 <sup>th</sup> Sony Research Forum 2001, pages 201-206				

<sup>\*</sup>EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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<sup>&#</sup>x27;Applicant's unique citation designation number (optional). <sup>2</sup>Applicant is to place a check mark here if English language Translation is attached.